

## **Search Notes**



**Application/Control No.**

10/577,612

**Examiner**

Qiuwen Mi

**Applicant(s)/Patent under  
Reexamination**

TSUBOI ET AL.

## Art Unit

1655

**SEARCHED**

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner